

References

- Banerjee, Sudipto, Bradley P. Carlin, and Alan E. Gelfand (Dec. 17, 2003). *Hierarchical Modeling and Analysis for Spatial Data*. CRC Press. 470 pp.
- Breslow, N. E. and D. G. Clayton (Mar. 1, 1993). “Approximate Inference in Generalized Linear Mixed Models”. *Journal of the American Statistical Association* 88.421, pp. 9–25.
- Caffo, Brian S., Wolfgang Jank, and Galin L. Jones (2005). “Ascent-Based Monte Carlo Expectation-Maximization”. *Journal of the Royal Statistical Society. Series B (Statistical Methodology)* 67.2. ArticleType: primary_article / Full publication date: 2005 / Copyright 2005 Royal Statistical Society, pp. 235–251.
- Cai, Tony and Weidong Liu (June 1, 2011). “Adaptive Thresholding for Sparse Covariance Matrix Estimation”. *Journal of the American Statistical Association* 106.494, pp. 672–684.
- Duane, Simon et al. (Sept. 3, 1987). “Hybrid Monte Carlo”. *Physics Letters B* 195.2, pp. 216–222.
- Durbin, James and Siem Jan Koopman (May 3, 2012). *Time Series Analysis by State Space Methods: Second Edition*. Oxford University Press. 370 pp.
- Efron, Bradley and R. J. Tibshirani (May 15, 1994). *An Introduction to the Bootstrap*. CRC Press. 456 pp.
- Everitt, Brian (2011). *Cluster Analysis*. 5th ed. Wiley series in probability and statistics. Hoboken: Wiley.
- Gelman, Andrew and Jennifer Hill (Dec. 18, 2006). *Data Analysis Using Regression and Multi-level/Hierarchical Models*. Cambridge University Press. 651 pp.
- Gilks, W. R. (2005). “Markov Chain Monte Carlo”. *Encyclopedia of Biostatistics*. John Wiley & Sons, Ltd.
- Gneiting, Tilmann and Adrian E Raftery (Mar. 1, 2007). “Strictly Proper Scoring Rules, Prediction, and Estimation”. *Journal of the American Statistical Association* 102.477, pp. 359–378.
- Guennebaud, Gal and Benoit Jacob (2010). *Eigen*. URL: <http://eigen.tuxfamily.org>.
- Haario, Heikki, Eero Saksman, and Johanna Tamminen (1999). “Adaptive proposal distribution for random walk Metropolis algorithm”. *Computational Statistics* 3.
- Harvey, Andrew C (1993). *Time series models*. 2nd ed. Cambridge, Massachusetts: The MIT Press.